

Search Notes

Application/Control No.

10/691,440

Examiner

Trinh T. Nguyen

Applicant(s)/Patent under
Reexamination

ATKEY ET AL.

Art Unit

3644

SEARCHED

Class	Subclass	Date	Examiner
updated	all	8/15/2005	TTN
previous	searches	↓	↓
as	indicated		
on	search		
notes	2/3/05		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR